SN75LV4737A 3.3-V/5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER

SLLS178D - APRIL 1994 - REVISED FEBRUARY 2000

- Single-Chip and Single-Supply Interface for IBM PC/AT™ Serial Port
- Meets or Exceeds the Requirements of TIA/EIA-232-F and ITU v.11 Standards
- Operates With 3.3-V or 5-V Supplies
- One Receiver Remains Active During Standby (Wake-up Mode)
- Designed to Operate at 128 kbit/s Over a 3-m Cable
- Low Standby Current . . . 5 μA Max
- ESD Protection on RS-232 Pins Meets or Exceeds 4 kV (HBM) and 1.5 kV (HBM) on All Pins Per MIL-STD-883, Method 3015
- External Capacitors . . . 0.1 μF
 (V_{CC} = 3.3 V . . . Five External Capacitors)
 (V_{CC} = 5 V . . . Four External Capacitors)
- Accepts 5-V Logic Input With 3.3-V Supply
- Applications
 - RS-232 Interface
 - Battery-Powered Systems, PDAs
 - Notebook, Laptop, and Palmtop PCs
 - External Modems and Hand-Held Terminals
- Packaged in Shrink Small-Outline Package

DB PACKAGE† (TOP VIEW) V_{DD} 28 T C3+ C2+ **∏** 27 GND 2 26 C3-V_{СС} 🛮 з 25 🛮 V_{SS} C2- Π EN [] 5 24 T C1-C1+ [] 6 23 STBY DIN1 [22 DOUT1 DIN2 [21 DOUT2 8 20 DOUT3 DIN3 I 9 19 🛮 RIN1 ROUT1 10 18 RIN2 ROUT2 11 ROUT3 12 17 RIN3 **ROUT4 1** 13 16 RIN4 15 RIN5 ROUT5 14

† The DB package is only available in left-ended tape and reel (order part number SN75LV4737ADBR).

description

The SN75LV4737A[‡] consists of three line drivers, five line receivers, and a charge-pump circuit. It provides the electrical interface between an asynchronous communication controller and the serial-port connector, and meets the requirements of TIA/EIA-232-F. This combination of drivers and receivers matches those needed for the typical serial port used in an IBM PC/AT or compatibles. The charge pump and five small external capacitors allow operation from a single 3.3-V supply, and four capacitors allow operation from a 5-V supply.

The device has flexible control options for power management when the serial port is inactive. A common disable for all of the drivers and receivers is provided with the active-high STBY input. The active-low \overline{EN} input is an enable for one receiver to implement a wake-up feature for the serial port. All the logic inputs can accept signals from controllers operating from a 5-V supply, even though the SN75LV4737A is operating from 3.3 V.

The SN75LV4737A is characterized for operation over the temperature range of 0°C to 70°C.



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‡ Patent-pending design

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Function Tables

EACH DRIVER

INP	UTS	OUTPUT
DIN	STBY	DOUT
Х	Н	Z
L	L	Н
Н	L	L
Open	L	L

H = high level, L = low level, X = irrelevant, Z = high impedance

EACH RECEIVER

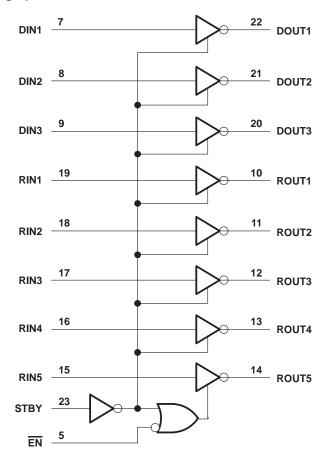
INPUTS			OUTPUTS				
STBY	EN	RIN5	RIN1-RIN4	ROUT5 ROUT1-RO			
Н	Н	Х	Х	Z	Z		
Н	L	Н	X	L	Z		
Н	L	L	Χ	Н	Z		
L	Χ	L	L	Н	Н		
L	Χ	Н	Н	L	L		

H = high level, L = low level, X = irrelevant, Z = high impedance

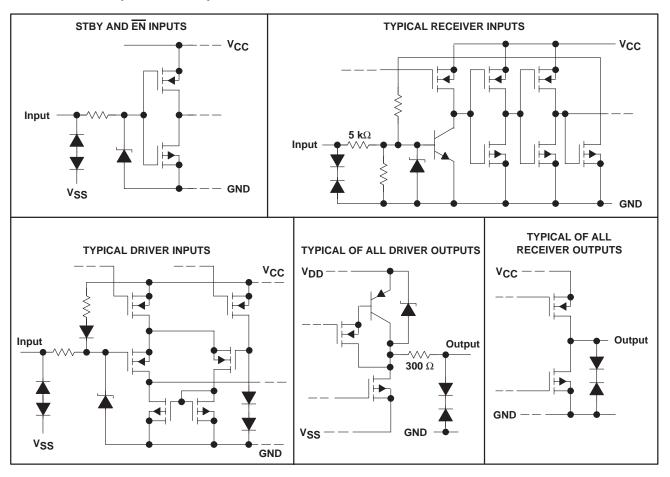


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logic diagram (positive logic)



schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	
Positive output supply voltage, V _{DD} (see Note 1)	
Negative output supply voltage, V _{SS}	–15 V
Input voltage range, V _I : Driver	–3 V to 7 V
Receiver	
Output voltage range, VO: Driver	V_{SS} – 0.3 V to V_{DD} + 0.3 V
Receiver	0.3 V to 7 V
Package thermal impedance, θ _{JA} (see Note 2)	62°C/W
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds .	260°C
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages are with respect to network GND.

2. The package thermal impedance is calculated in accordance with JESD 51.



SN75LV4737A 3.3-V/5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER

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recommended operating conditions

					NOM	MAX	UNIT
\/aa	Va a Cumhuvoltaga		V _{CC} = 3.3 V	3	3.3	3.6	V
Vcc	Supply voltage	ge		4.5	5	5.5	V
		DIN, EN, STBY	V _{CC} = 3.3 V	2			
VIH	Driver high-level input voltage	DIN	V	2			V
		EN, STBY	V _{CC} = 5 V	2.5			
VIL	Driver low-level input voltage	DIN, EN, STBY	DIN, EN, STBY			0.8	V
VI	Receiver input voltage					±30	V
	External capacitor	3.3-V operation (C1, C2, C3, C4, C5), 5-V operation (C1, C3, C4, C5), See Note 3 and Figures 6 and 7		0.1			μF
TA	Operating free-air temperature			0		70	°C

NOTE 3: C2 is needed only for 3.3-V operation.

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (see Figures 6 and 7) (unless otherwise noted)

	PARAMETER		TEST CONDITIONS		V _{CC} = 3.3 V		V _{CC} = 5 V			UNIT
	PANAMETER	1231	CONDITIONS	MIN	TYP†	MAX	MIN	TYP [†]	MAX	ONIT
V_{DD}	Positive supply voltage	No load		8	10		7	8.7		V
Vss	Negative supply voltage	No load			-9.5	-7		-8	-6	V
Ц	Input current (EN, STBY)	See Notes 4 and 5				±2			±2	μΑ
	Supply current		STBY at GND, EN at V _{CC} or GND	8.4	10	18	10	12	20.7	mA
ICC	Supply current (standby mode) (see Note 4)	No load, Inputs open	EN, STBY at V _{CC}			5			5	4
	Supply current (wake-up mode) (see Note 5)		EN at GND, STBY at V _{CC}			10			10	μΑ

† All typical values are at $V_{CC} = 3.3 \text{ V}$ or $V_{CC} = 5 \text{ V}$, and $T_A = 25^{\circ}\text{C}$. NOTES: 4. When standby mode is not used, <u>STBY</u> input must be taken low.

5. When wake-up mode is not used, EN input must be taken high.



DRIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS			TYP [†]	MAX	UNIT
Vон	High-level output voltage	$R_L = 3 k\Omega$		5.5	7		V
VOL	Low-level output voltage	$R_L = 3 k\Omega$			-6	- 5	V
lн	High-level input current	$V_I = V_{CC}$				1	μΑ
Ι _Ι L	Low-level input current	V _I at GND				-10	μΑ
laa	Short-circuit output current (see Note 6)	V _{CC} = 3.6 V,	VO = 0 V		±15	+40	mA
los	Short-circuit output current (see Note 6)	V _{CC} = 5.5 V,	VO = 0 V		±15	±40	IIIA
r _O	Output resistance	$V_{CC} = V_{DD} = V_{SS} = 0 V$	V _O = ±2 V	300	500		Ω

† All typical values are at $V_{CC} = 3.3 \text{ V}$ or $V_{CC} = 5 \text{ V}$, and $T_A = 25^{\circ}\text{C}$. NOTE 6: Short-circuit durations should be controlled to prevent exceeding the device absolute maximum power dissipation ratings, and not more than one output should be shorted at a time.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST COM	NDITIONS	MIN	TYP [†]	MAX	UNIT
+	Propagation delay time, low- to high-level output		V _{CC} = 3.3 V	100	500	850	ns
^t PLH	Propagation delay time, low- to high-level output	$C_L = 50 \text{ pF},$ $R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$	V _{CC} = 5 V	100	500	850	115
tou	Propagation delay time, high- to low-level output	See Figure 1	V _{CC} = 3.3 V	100	500	850	ns
tPHL	Propagation delay time, high- to low-level output	3	V _{CC} = 5 V	100	500	850	115
tPZH	Output enable time to high level	C _L = 50 pF,	$R_L = 3 k\Omega$ to $7 k\Omega$,		1	5	ms
tPZL	Output enable time to low level	See Figure 2			3	7	ms
+	Output disable time from high level		V _{CC} = 3.3 V		0.9	3	
^t PHZ		C _L = 50 pF,	V _{CC} = 5 V		0.6	3	μs
	Output disable time from low level	R_L = 3 kΩ to 7 kΩ, See Figure 2	V _{CC} = 3.3 V		0.5	3	
tPLZ	Output disable time from low level	3	V _{CC} = 5 V		0.3	3	μs
SR	Slew rate	C _L = 50 pF, See Figure 1	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$	4		30	V/μs
SR(tr)	Slew rate, transition region	C _L = 2500 pF, See Figure 3	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$	3		30	V/μs

[†] All typical values are at $V_{CC} = 3.3 \text{ V}$ or $V_{CC} = 5 \text{ V}$, and $T_A = 25^{\circ}\text{C}$.



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RECEIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

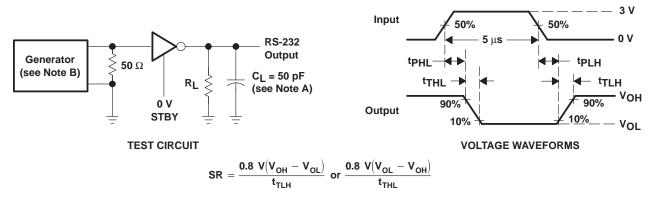
	PARAMETER	TEST COND	MIN	TYP [†]	MAX	UNIT	
Vou	High-level output voltage	I _{OH} = -2 mA	V _{CC} = 3.3 V	2.4	3		V
VOH	riigh-ievel output voitage	10H = -2 IIIA	V _{CC} = 5 V	3.5	5		٧
VOL	Low-level output voltage	I _{OL} = 2 mA			0.2	0.4	V
V _{IT+}	Positive-going input threshold voltage				2.2	2.6	V
VIT-	Negative-going input threshold voltage			0.6	1		V
V _{hys}	Input hysteresis (V _{IT+} - V _{IT-})			0.5	1.2	1.8	V
rį	Input resistance	$V_{ } = \pm 3 \text{ V to } \pm 25 \text{ V}$		3	5	7	kΩ

[†] All typical values are at $V_{CC} = 3.3 \text{ V}$ or $V_{CC} = 5 \text{ V}$, and $T_A = 25^{\circ}\text{C}$.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF, R_L = 3 k Ω to GND

	PARAMETER		٧c	C = 3.3	٧	V	CC = 5 V	'	UNIT
	PARAINETER	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
t _{PLH}	Propagation delay time, low- to high-level output		10	70	200	10	70	200	ns
tPHL	Propagation delay time, high- to low-level output	1 i	10	60	200	10	55	200	ns
tPLH	Propagation delay time, low- to high-level output (wake-up mode)	See Figure 4		40	200		40	200	μs
tPHL	Propagation delay time, high- to low-level output (wake-up mode)			90	500		70	500	ns
^t PZH	Output enable time to high level			3	10		1.2	10	μs
tPZL	Output enable time to low level	See Figure 5		100	250		60	250	ns
tPHZ	Output disable time from high level		100	200	600	100	150	600	ns
tPLZ	Output disable time from low level			130	250		60	250	ns

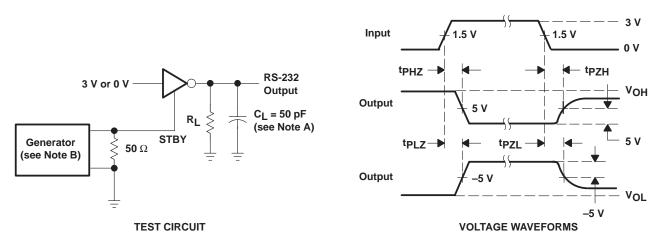
PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

B. The pulse generator has the following characteristics: $Z_O = 50 \ \Omega$, 50% duty cycle, $t_\Gamma \le 10 \ ns$, $t_f \le 10 \ ns$.

Figure 1. Driver Propagation Delay Times and Slew Rate (5-μs Input)



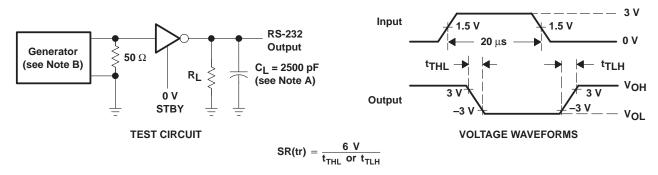
NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: $Z_O = 50 \ \Omega$, 50% duty cycle, $t_\Gamma \le 10 \ ns$, $t_f \le 10 \ ns$.

Figure 2. Driver Enable and Disable Test Times

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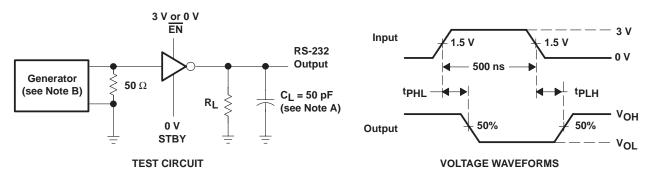
PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: $Z_O = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns. $t_f \le 10$ ns.

Figure 3. Driver Transition Times and Slew Rate (20-μs Input)

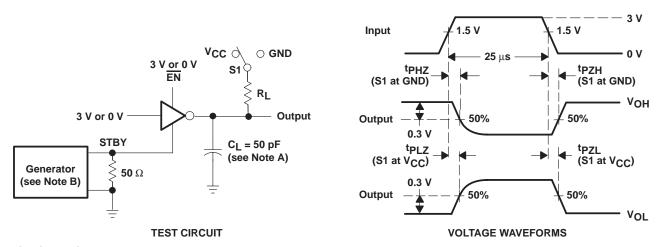


NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 1 MHz, $Z_O = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

Figure 4. Receiver Propagation Delay Times

PARAMETER MEASUREMENT INFORMATION



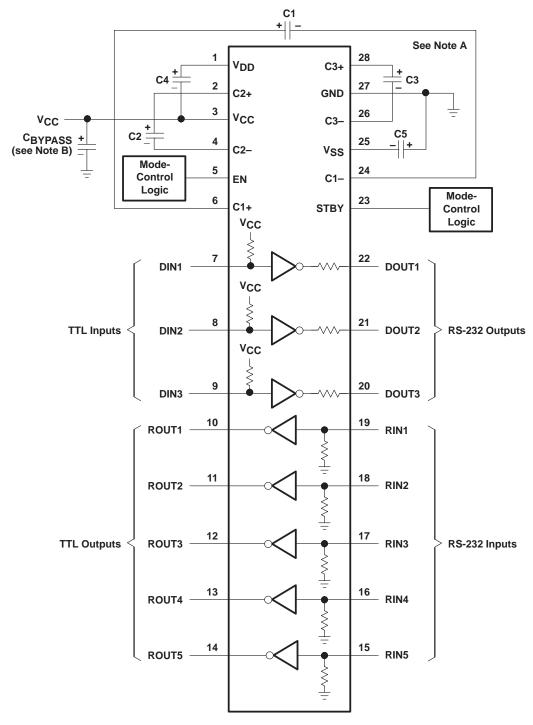
NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 1 MHz, Z_O = 50 Ω , 50% duty cycle, $t_r \le 10$ ns. $t_f \le 10$ ns.

Figure 5. Receiver Enable and Disable Times



APPLICATION INFORMATION



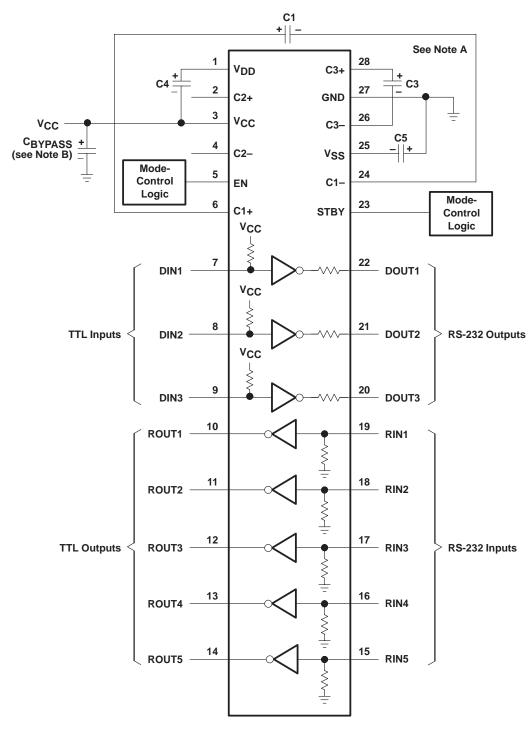
NOTES: A. $C1 = C2 = C3 = C4 = C5 = C_{BYPASS} = 0.1 \mu F$

B. CBYPASS is used as a decoupling capacitor.

Figure 6. Typical 3.3-V Operating Circuit



APPLICATION INFORMATION



NOTES: A. C2 is not used. C1 = C3 = C4 = C5 = $C_{BYPASS} = 0.1 \mu F$

B. CBYPASS is used as a decoupling capacitor.

Figure 7. Typical 5-V Operating Circuit



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